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IC Package Inspection Project

The on-axis diffuse light is a good alternative for the more expensive square
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 As the electrons diffuse away from the hot probe, they leave behind the positively
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 defects outside the light probe are illuminated by light. coming from scatterers
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 of the light emergent from the quarter-wave plate. The fast axis of the sample
 should be inclined ... pinning of the IC structure at frozen-in defects [24]. ...
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Patients considered IC to be important and expected all pertinent ... Peripheral
 light focusing caused by off-axis light was calculated for light rays ...
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Triple-axis diffraction (TAD)--by separating the specular and diffuse scattered
 ... [2]: Bassignana IC and Macquistan DA, Common Themes and Mechanisms of ...
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IC Insights - Glossary of Terms

Electrons are **light** in mass (1/1837 of the mass of the hydrogen atom), highly mobile, ... A **defect** in an IC that can cause a failure during operation. ...
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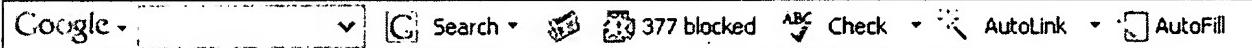
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